Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,245	HELD ET AL.	
Examiner	Art Unit	
Tu M. Nguyen	3748	

	SEAR	CHED	
Class	Subclass	Date	Examiner
60	274	1/200	6 TMN
	281		
	284		
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	292		
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123	184.53		
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INTERFERENCE SEARCHED						
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